

## P-Channel Enhancement Mode MOSFET

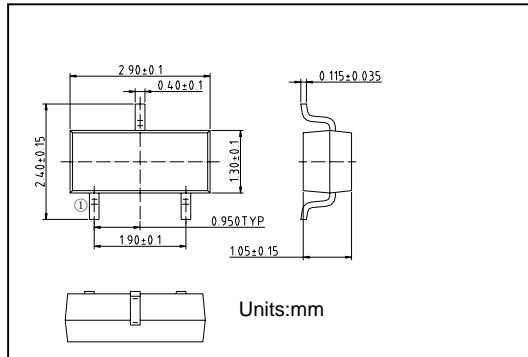
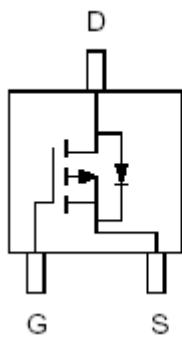
### • Features

- 20V/-2.8A ,  $R_{DS(ON)}=72\text{m}\Omega$  (typ.) @ VGS=-10V  
 $R_{DS(ON)}=100\text{m}\Omega$  (typ.) @ VGS=-4.5V
- Super High Dense Cell Design for Extremely Low  $R_{DS(ON)}$
- Reliable and Rugged
- SOT-23 Package

### • Applications

- Power Management in Notebook Computer
- Portable Equipment
- Battery Powered Systems.

### • Equivalent circuit



### • Absolute Maximum Ratings

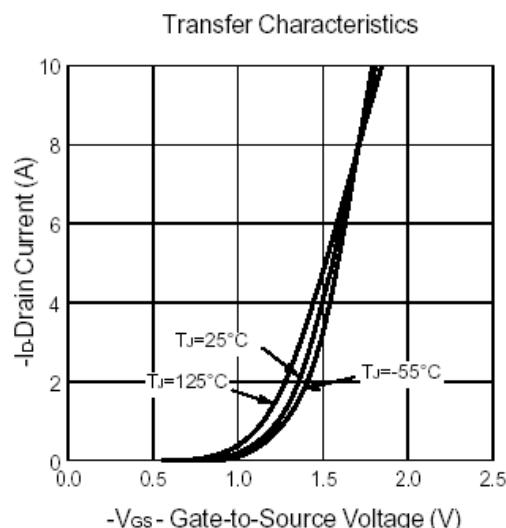
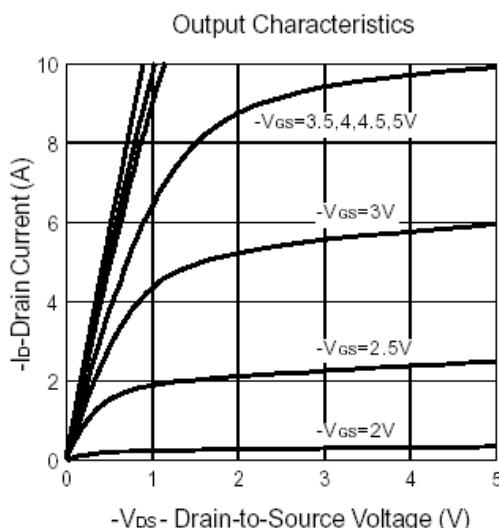
PARAMETER	SYMBOL	RATINGS	UNITS
Drain - Source Voltage	V <sub>dss</sub>	-20	V
Gate - Source Voltage	V <sub>gss</sub>	±16	V
Drain Current (DC)	I <sub>d</sub>	-2.8	A
Drain Current (Pulse)	I <sub>dp</sub>	-10	A
Maximum Power Dissipation	P <sub>d</sub> (TA=25°C)	1.25	W
	P <sub>d</sub> (TA=100°C)	0.5	W
Maximum Junction Temperature	T <sub>ch</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55~150	°C
Thermal Resistance - Junction to Ambient	R <sub>θjA</sub>	100	°C/W

**• Electrical Characteristics**
**Static**

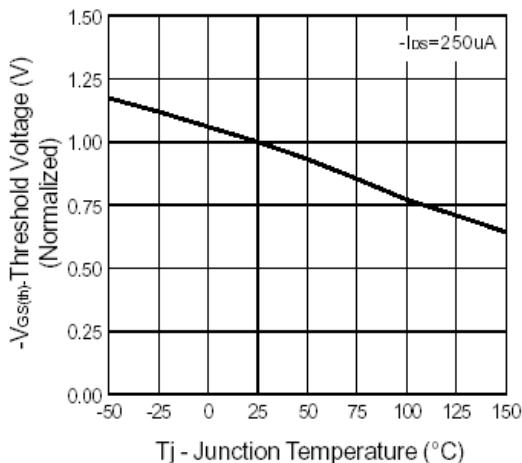
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_{DS} = -250 \mu A$	20			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -16V, V_{GS} = 0V$			1	$\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_{DS} = -250 \mu A$	0.6		1.5	V
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 16V, V_{DS} = 0V$			$\pm 100$	nA
Drain-Source On-state Resistance	$R_{DS(ON)}$	$V_{GS} = -10V, I_{DS} = -2.8A$		72	85	$m\Omega$
		$V_{GS} = -4.5V, I_{DS} = -2.5A$		98	100	
Diode Forward Voltage	$V_{DS}$	$V_{GS} = 0V, I_{DS} = -1.25A$	0.6		1.3	V

**Dynamic Characteristics  $T_a=25^\circ C$** 

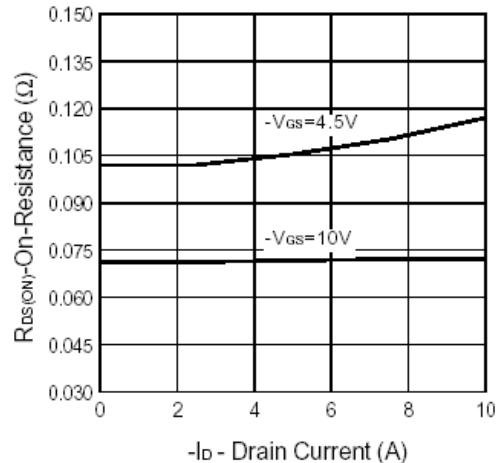
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Total Gate Charge	$Q_g$	$V_{DS} = -10V$ $V_{GS} = -4.5V$ $I_{DS} = -3A$		7.6	10	nC
Gate-Source Charge	$Q_{gs}$			3.2		
Gate-Drain Charge	$Q_{gd}$			2		
Turn-on Delay Time	$T_{d(ON)}$	$V_{DD} = -10V, I_{DS} = -1A$ $V_{GEN} = -4.5V$ $R_G = 6\Omega$ $R_L = 6\Omega$		11	22	nS
Turn-on Rise Time	$T_r$			32	55	
Turn-off Delay Time	$T_{d(OFF)}$			38	68	
Turn-off Rise Time	$T_f$			32	55	
Input Capacitance	$C_{iss}$	$V_{DS} = -15V$ $V_{GS} = 0V$ $f = 1 MHz$		430		pF
Output Capacitance	$C_{oss}$			235		
Reverse Transfer Capacitance	$C_{rss}$			95		

**• Typical Performance Characteristics**


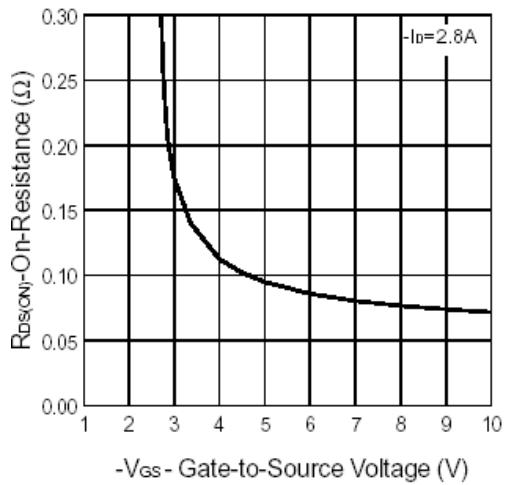
Threshold Voltage vs. Junction Temperature



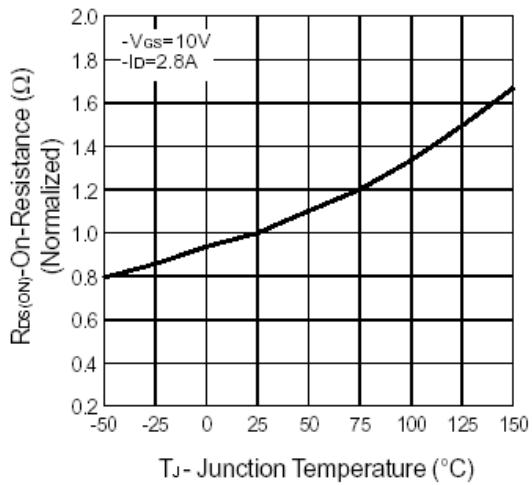
On-Resistance vs. Drain Current



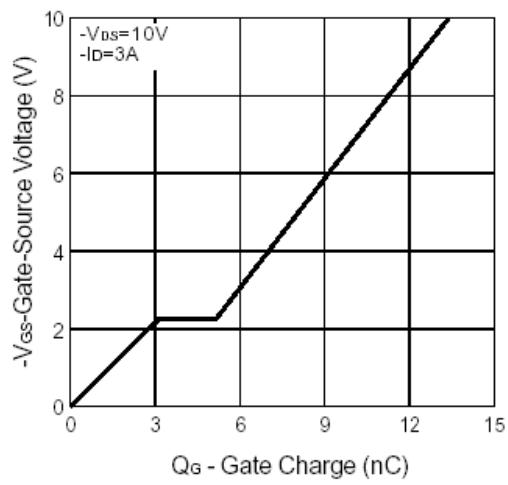
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Junction Temperature



Gate Charge



Capacitance

